











SN54LVC374A, SN74LVC374A

SCAS296O - JANUARY 1993-REVISED JULY 2014

SNx4LVC374A Octal Edge-Triggered D-Type Flip-Flops With 3-State Outputs

Features

- Operate From 1.65 V to 3.6 V
- Inputs Accept Voltages to 5.5 V
- Max t_{pd} of 6.5 ns at 3.3 V
- Typical V_{OLP} (Output Ground Bounce) $<0.8 \text{ V at V}_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$
- Typical V_{OHV} (Output V_{OH} Undershoot) >2 V at V_{CC} = 3.3 V, T_A = 25°C
- Support Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V V_{CC})
- Ioff Supports Live Insertion, Partial-Power-Down Mode, and Back-Drive Protection
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

2 Applications

- Electronic Points of Sale
- TV Set-top Boxes
- Infotainment
- Servers
- **Appliances**

Description

The SN54LVC374A octal edge-triggered D-type flipflop is designed for 2.7-V to 3.6-V V_{CC} operation, and the SN74LVC374A octal edge-triggered D-type flipflop is designed for 1.65-V to 3.6-V V_{CC} operation.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
	PDIP (20)	25.40 mm x 6.35 mm
	VQFN (20)	4.50 mm x 3.50 mm
SNx4LVC374A	SOIC (20)	12.80 mm x 7.50 mm
	SSOP (20)	7.20 mm x 5.30 mm
	TVSOP (20)	5.00 mm x 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Simplified Schematic

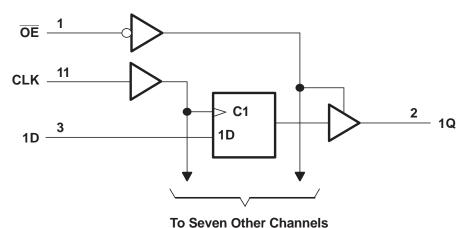




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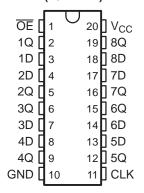
5 Revision History

С	hanges from Revision N (May 2005) to Revision O	Page
•	Updated data sheet temperature range	1
•	Updated I _{off} bullet in Features list.	1
•	Added Applications.	1
•	Added Pin Functions table	3
•	Added Handling Ratings table	4
•	Changed MAX operating temperature range from 85°C to 125°C in Recommended Operating Conditions table	5
•	Added Thermal Information table	5
•	Added –40°C TO 125°C for SN74LVC374A to Electrical Characteristics table.	6
•	Added Timing Requirements table for SN74LVC374A at -40°C TO 125°C.	<mark>7</mark>
•	Added Switching Characteristics table for SN74LVC374A -40°C TO 125°C.	8
•	Added Typical Characteristics.	9
•	Added Detailed Description section	11
•	Added Applications and Implementation section.	12
•	Added Power Supply Recommendations and Layout sections	13

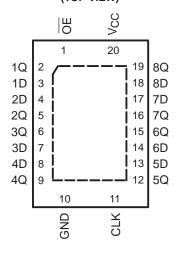


6 Pin Configuration and Functions

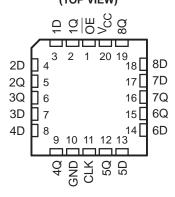
SN54LVC374A...J OR W PACKAGE SN74LVC374A...DB, DGV, DW, N, NS, OR PW PACKAGE (TOP VIEW)



SN74LVC374A . . . RGY PACKAGE (TOP VIEW)



SN54LVC374A . . . FK PACKAGE (TOP VIEW)



Pin Functions

Р	IN	1/0	DESCRIPTION
NO.	NAME	I/O	DESCRIPTION
1	ŌĒ	I	Enable pin
2	1Q	0	Output 1
3	1D	I	Input 1
4	2D	I	Input 2
5	2Q	0	Output 2
6	3Q	0	Output 3
7	3D	I	Input 3
8	4D	I	Input 4
9	4Q	0	Output 4
10	GND	_	Ground pin
11	CLK	I	Clock
12	5Q	0	Output 5
13	5D	I	Input 5
14	6D	I	Input 6
15	6Q	0	Output 6
16	7Q	0	Output 7
17	7D	I	Input 7
18	8D	I	Input 8
19	8Q	0	Output 8
20	VCC	_	Power pin

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7 Specifications

7.1 Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	6.5	V
VI	Input voltage range (2)	-0.5	6.5	V	
Vo	Voltage range applied to any output in the high-im	-0.5	6.5	V	
Vo	Voltage range applied to any output in the high or	-0.5	V _{CC} + 0.5	V	
I_{IK}	Input clamp current	V _I < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
Io	Continuous output current			±50	mA
	Continuous current through V _{CC} or GND	·		±100	mA

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions are not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 Handling Ratings

			MIN	MAX	UNIT
T _{stg}	Storage temperature rang	torage temperature range			
V	Flootroctatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	0	2	kV
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	0	1000	V

JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as 500 V
may actually have higher performance.

²⁾ The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

⁽³⁾ The value of V_{CC} is provided in the recommended operating conditions table.

⁽²⁾ JEĎEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Pins listed as 250 V may actually have higher performance.



7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

			SN54LVC	374A	SN74L	VC374A		
			MIN	MAX	MIN	MAX	UNIT	
\/	Cumply valtage	Operating	2	3.6	1.65	3.6	V	
V_{CC}	Supply voltage	Data retention only	1.5		1.5		V	
		V _{CC} = 1.65 V to 1.95 V			0.65 × V _{CC}			
V_{IH}	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$			1.7		V	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		2			
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$				$0.35 \times V_{CC}$		
V_{IL}	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$				0.7	V	
		V _{CC} = 2.7 V to 3.6 V		0.8		0.8		
V_{I}	Input voltage		0	5.5	0	5.5	V	
.,	Output voltage	High or low state	0	V_{CC}	0	V_{CC}	V	
V _O	Output voltage	3-state	0	5.5	0	5.5		
		V _{CC} = 1.65 V				-4		
	High level output ourrent	$V_{CC} = 2.3 \text{ V}$				-8	mA	
I _{OH}	High-level output current	$V_{CC} = 2.7 \text{ V}$		-12		-12		
		V _{CC} = 3 V		-24		-24		
		V _{CC} = 1.65 V				4		
	Lavelaval autovit avenuet	V _{CC} = 2.3 V				8	mA	
l _{OL}	Low-level output current	$V_{CC} = 2.7 \text{ V}$		12		12		
		V _{CC} = 3 V		24		24		
Δt/Δν	Input transition rise or fall rate			10		10	ns/V	
T _A	Operating free-air temperature		-55	125	-40	125	°C	

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, (SCBA004).

7.4 Thermal Information

		SN74LVC374A	
	THERMAL METRIC ⁽¹⁾	PW	UNIT
		20 PIN	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	102.5	
$R_{\theta JCtop}$	Junction-to-case (top) thermal resistance	35.9	
$R_{\theta JB}$	Junction-to-board thermal resistance	53.5	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	2.2	
ΨЈВ	Junction-to-board characterization parameter	52.9	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, (SPRA953).

Product Folder Links: SN54LVC374A SN74LVC374A



7.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

			CNEA	I VC274A		SN74	LVC374A		SI	N74LVC374A		
PARAMETER	TEST CONDITIONS	V _{cc}	V _{CC} SN54LVC374A			-40°C TO 85°C			-40	0°C TO 125°C		UNIT
			MIN	TYP ⁽¹⁾	MAX	MIN	TYP ⁽¹⁾	MAX	MIN	TYP ⁽¹⁾	MAX	
	1. 400.00	1.65 V to 3.6 V				V _{CC} - 0.2			V _{CC} - 0.2			
	I _{OH} = -100 μA	2.7 V to 3.6 V	V _{CC} - 0.2									
V_{OH}	I _{OH} = -4 mA	1.65 V				1.2			1.20			V
VOH	$I_{OH} = -8 \text{ mA}$	2.3 V				1.7			1.70			•
	I 42 m A	2.7 V	2.2			2.2			2.20			
	I _{OH} = -12 mA	3 V	2.4			2.4			2.40			
	I _{OH} = -24 mA	3 V	2.2			2.2			2.20			
	l _{OL} = 100 μA	1.65 V to 3.6 V						0.2			0.20	
		2.7 V to 3.6 V			0.2							
V_{OL}	I _{OL} = 4 mA	1.65 V						0.45			0.45	V
	I _{OL} = 8 mA	2.3 V						0.7			0.70	
	I _{OL} = 12 mA	2.7 V			0.4			0.4			0.40	
	I _{OL} = 24 mA	3 V			0.55			0.55			0.55	
l _l	V _I = 0 to 5.5 V	3.6 V			±5			±5			±5	μA
I _{off}	V _I or V _O = 5.5 V	0						±10			±20	μA
l _{oz}	V _O = 0 to 5.5 V	3.6 V			±15			±10			±15	μA
	V _I = V _{CC} or GND	0.01/			10			10			10	
I _{cc}	$3.6 \text{ V} \le \text{V}_{\text{I}} \le 5.5 \text{ V}^{(2)}$	3.6 V			10			10			10	μΑ
ΔI _{CC}	One input at V _{CC} - 0.6 V, Other inputs at V _{CC} or GND	2.7 V to 3.6 V			500			500			500	μΑ
Ci	V _I = V _{CC} or GND	3.3 V		4	12		4		75	4		pF
C _o	V _O = V _{CC} or GND	3.3 V		5.5	12		5.5			5.5		pF

⁽¹⁾ All typical values are at V_{CC} = 3.3 V, T_A = 25°C. (2) This applies in the disabled state only.



7.6 Timing Requirements, SN54LVC374A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

			SN54LVC374A					
	PARAMETER	V _{CC} = 2	2.7 V	V _{CC} = 3.3 V ± 0.3 V		UNIT		
			MAX	MIN	MAX			
f _{clock}	Clock frequency		80		100	MHz		
t _w	Pulse duration, CLK high or low	3.3		3.3		ns		
t _{su}	Setup time, data before CLK↑	2		2		ns		
t _h	Hold time, data after CLK↑	1.5		1.5		ns		

7.7 Timing Requirements, SN74LVC374A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

			SN74LVC374A -40°C TO 85°C							
PARAMETER										
			V _{CC} = 1.8 V V _{CC} = 2.5 V ± 0.15 V ± 0.2 V		V _{CC} =	= 2.7 V V _{CC} = ± 0.3			UNIT	
			MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f _{clock}	Clock frequency		55		95		80		100	MHz
t _w	Pulse duration, CLK high or low	9		4		3.3		3.3		ns
t _{su}	Setup time, data before CLK↑	6		4		2		2		ns
t _h	Hold time, data after CLK↑	4		2		1.5		1.5		ns

7.8 Timing Requirements, SN74LVC374A

0	rining requirements, our 421 cor 42									
		SN74LVC374A								
PARAMETER					–40°C T	O 85°C				
			V _{CC} = 1.8 V \ ± 0.15 V		2.5 V 2 V	V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f _{clock}	Clock frequency		40		80		80		100	MHz
t _w	Pulse duration, CLK high or low	9		4		3.3		3.3		ns
t_{su}	Setup time, data before CLK↑	6		4		2		2		ns
t _h	Hold time, data after CLK↑	4		2		1.5		1.5		ns

7.9 Switching Characteristics, SN54LVC374A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

				SN54L\	/C374A		
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 3 ± 0.3	V _{CC} = 3.3 V ± 0.3 V			
			MIN	MAX	MIN	MAX	
f _{max}			80		100		MHz
t _{pd}	CLK	Q		9.5	1	8.5	ns
t _{en}	ŌĒ	Q		9.5	1	8.5	ns
t _{dis}	ŌĒ	Q		8	1	7	ns

Product Folder Links: SN54LVC374A SN74LVC374A



7.10 Switching Characteristics, SN74LVC374A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

						SN74L\	/C374A					
	FDOM	то	-40°C TO 85°C									
PARAMETER	FROM (INPUT)	(OUTPUT)	V _{CC} = 1.8 V ± 0.15 V V _{CC} = 2.5 V ± 0.2 V V _{CC} =							3.3 V 3 V	UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
f _{max}			55		95		80		100		MHz	
t _{pd}	CLK	Q		21.9		10.8		8.1	1.5	7	ns	
t _{en}	ŌĒ	Q		19.8		10.8		8.5	1.5	7.5	ns	
t _{dis}	ŌĒ	Q		19.1		18.1		7.1	1.5	6.5	ns	
t _{sk(o)}				1		1		1		1	ns	

7.11 Switching Characteristics, SN74LVC374A

over operating free-air temperature range (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 1 ± 0.1	1.8 V 5 V	V _{CC} = 2 ± 0.2	2.5 V ! V	V _{CC} =	2.7 V	V _{CC} = ± 0.	3.3 V 3 V	UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f _{max}			55		95		80		100		MHz
t _{pd}	CLK	Q		21.9		10.8		8.1	1.5	7.6	ns
t _{en}	ŌĒ	Q		19.8		10.8		8.9	1.5	8.0	ns
t _{dis}	ŌĒ	Q		19.1		18.1		7.7	1.5	7.0	ns
t _{sk(o)}				1.5		1.5		1.5		1.5	ns

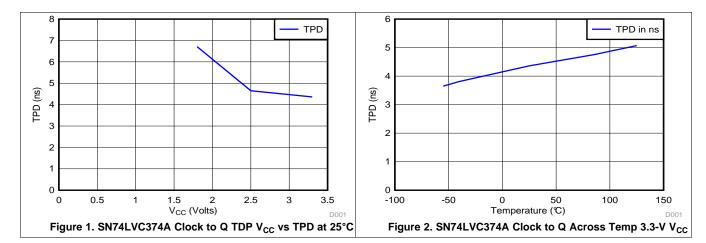
7.12 Operating Characteristics

 $T_{\Delta} = 25^{\circ}C$

	PARAMETER		TEST CONDITIONS	V _{CC} = 1.8 V TYP	V _{CC} = 2.5 V TYP	V _{CC} = 3.3 V TYP	UNIT
	Dower discination conscitance	Outputs enabled		53	54	54.5	
C _{pd}	Power dissipation capacitance per flip-flop	Outputs disabled	f = 10 MHz	12	15	13.5	pF

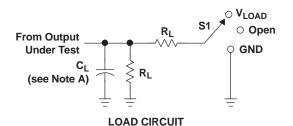


7.13 Typical Characteristics



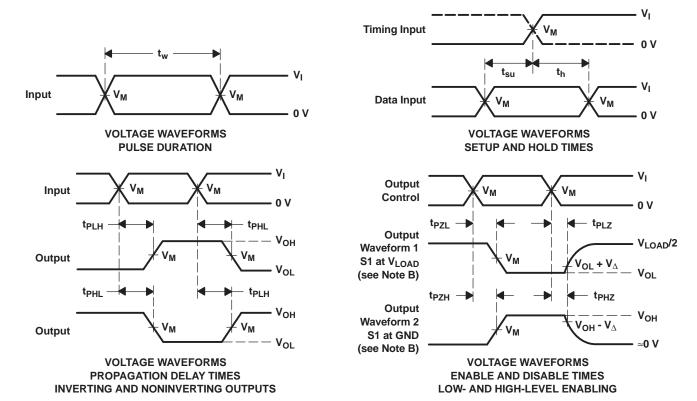


8 Parameter Measurement Information



TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	V _{LOAD}
t _{PHZ} /t _{PZH}	GND

V	INF	PUTS	V	V	•		V
V _{CC}	VI	t _r /t _f	V _M	V _{LOAD}	CL	R _L	V_{Δ}
1.8 V ± 0.15 V	V _{CC}	≤2 ns	V _{CC} /2	2×V _{CC}	30 pF	1 k Ω	0.15 V
2.5 V \pm 0.2 V	V _{CC}	≤ 2 ns	V _{CC} /2	2 × V _{CC}	30 pF	500 Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
3.3 V \pm 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50~\Omega$.
- D. The outputs are measured one at a time with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis}.
- F. t_{PZL} and t_{PZH} are the same as t_{en}.
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .
- H. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms

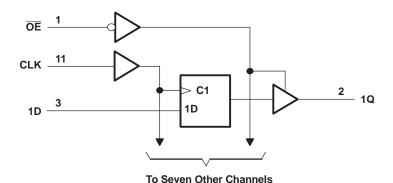


9 Detailed Description

9.1 Overview

These devices feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. These devices are particularly suitable for implementing buffer registers, input/output (I/O) ports, bidirectional bus drivers, and working registers. On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels set up at the data (D) inputs. A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components. \overline{OE} does not affect internal operations of the latch. Old data can be retained or new data can be entered while the outputs are in the high-impedance state. Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment. These devices are fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down. To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

9.2 Functional Block Diagram



9.3 Feature Description

- · Wide operating voltage range
 - Operates from 1.65 V to 3.6 V
- · Allows down voltage translation
 - Inputs accept voltages to 5.5 V
- I_{off} feature
 - Allows voltages on the inputs and outputs when V_{CC} is 0 V

9.4 Device Functional Modes

Function Table (Each Flip-Flop)

	INPUTS		OUTPUT
ŌĒ	CLK	D	Q
L	↑	Н	Н
L	↑	L	L
L	H or L	Χ	Q_0
Н	Χ	X	Z

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Product Folder Links: SN54LVC374A SN74LVC374A

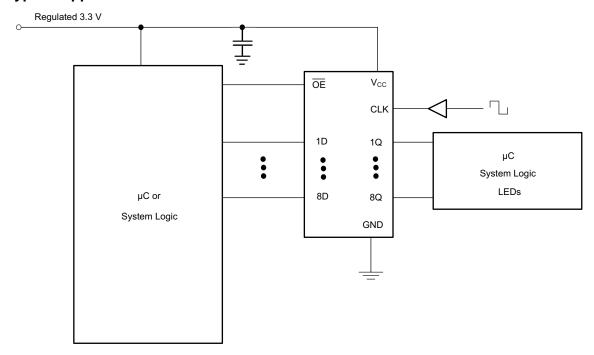


10 Applications and Implementation

10.1 Application Information

The SN74LVC374A is a high-drive CMOS device that can be used for a multitude of bus interface type applications where the data needs to be retained or latched. It can produce 32 mA of drive current at 3.3 V; therefore, making it ideal for driving multiple outputs and good for high speed applications up to 100 MHz. The inputs are 5.5-V tolerant allowing it to translate down to V_{CC} .

10.2 Typical Application



10.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads so routing and load conditions should be considered to prevent ringing.

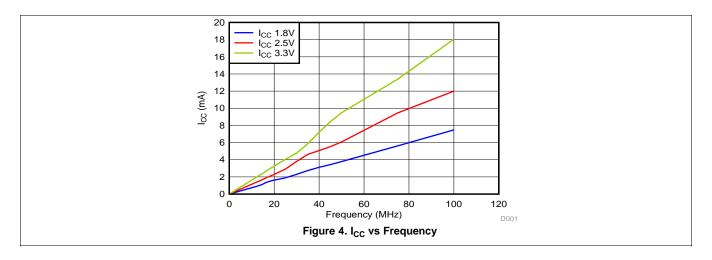
10.2.2 Detailed Design Procedure

- 1. Recommended Input conditions
 - Rise time and fall time specs: See $(\Delta t/\Delta V)$ in Recommended Operating Conditions table.
 - Specified high and low levels: See (V_{IH} and V_{IL}) in Recommended Operating Conditions table.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V_{CC}.
- 2. Recommend output conditions
 - Load currents should not exceed 25 mA per output and 50 mA total for the part.
 - Outputs should not be pulled above V_{CC}.



Typical Application (continued)

10.2.3 Application Curves



11 Power Supply Recommendations

The power supply can be any voltage between the Min and Max supply voltage rating located in the *Recommended Operating Conditions* table.

Each V_{CC} pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1- μ F capacitor is recommended. If there are multiple V_{CC} pins, then a 0.01- μ F or 0.022- μ F capacitor is recommended for each power pin. It is ok to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

12 Layout

12.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float. In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input terminals should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Figure 5 shows the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} whichever makes more sense or is more convenient. It is generally acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable terminal it will disable the outputs section of the part when asserted. This will not disable the input section of the IOs so they also cannot float when disabled.

12.2 Layout Example



Figure 5. Layout Diagram



13 Device and Documentation Support

13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
SN54LVC374A	Click here	Click here	Click here	Click here	Click here
SN74LVC374A	SN74LVC374A Click here		Click here	Click here	Click here

13.2 Trademarks

All trademarks are the property of their respective owners.

13.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

13.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





10-Jun-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9757401Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962- 9757401Q2A SNJ54LVC 374AFK	Sample
5962-9757401QRA	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9757401QR A SNJ54LVC374AJ	Sample
5962-9757401QSA	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9757401QS A SNJ54LVC374AW	Sample
5962-9757401V2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962- 9757401V2A SNV54LVC 374AFK	Sample
5962-9757401VRA	ACTIVE	CDIP	J	20	20	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9757401VR A SNV54LVC374AJ	Sample
5962-9757401VSA	ACTIVE	CFP	W	20	25	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9757401VS A SNV54LVC374AW	Sample
SN74LVC374ADBLE	OBSOLETE	SSOP	DB	20		TBD	Call TI	Call TI	-40 to 85		
SN74LVC374ADBR	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC374A	Sample
SN74LVC374ADBRE4	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC374A	Sample
SN74LVC374ADGVR	ACTIVE	TVSOP	DGV	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC374A	Sample
SN74LVC374ADW	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC374A	Sample
SN74LVC374ADWE4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC374A	Sample
SN74LVC374ADWR	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC374A	Sample
SN74LVC374ADWRE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC374A	Sample





10-Jun-2014

Orderable Device	Status	Package Type	_	Pins	_	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
SN74LVC374AN	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	SN74LVC374AN	Samples
SN74LVC374ANSR	ACTIVE	SO	NS	20	20 2000 Green (RoHS CU NIPDAU Level-1-260C-UNLIM -40 to 85 & no Sb/Br)		-40 to 85	LVC374A	Samples		
SN74LVC374ANSRG4	ACTIVE	SO	NS	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC374A	Samples
SN74LVC374APW	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC374A	Samples
SN74LVC374APWLE	OBSOLETE	TSSOP	PW	20		TBD	Call TI	Call TI	-40 to 85		
SN74LVC374APWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU CU SN	Level-1-260C-UNLIM	-40 to 85	LC374A	Samples
SN74LVC374APWRG4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC374A	Samples
SN74LVC374APWT	ACTIVE	TSSOP	PW	20	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC374A	Samples
SN74LVC374ARGYR	ACTIVE	VQFN	RGY	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	LC374A	Samples
SN74LVC374ARGYRG4	ACTIVE	VQFN	RGY	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	LC374A	Samples
SNJ54LVC374AFK	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962- 9757401Q2A SNJ54LVC 374AFK	Samples
SNJ54LVC374AJ	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9757401QR A SNJ54LVC374AJ	Samples
SNJ54LVC374AW	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9757401QS A SNJ54LVC374AW	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

PACKAGE OPTION ADDENDUM



10-Jun-2014

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN54LVC374A, SN54LVC374A-SP, SN74LVC374A:

Catalog: SN74LVC374A, SN54LVC374A

Automotive: SN74LVC374A-Q1, SN74LVC374A-Q1

Enhanced Product: SN74LVC374A-EP, SN74LVC374A-EP

Military: SN54LVC374A

Space: SN54LVC374A-SP





10-Jun-2014

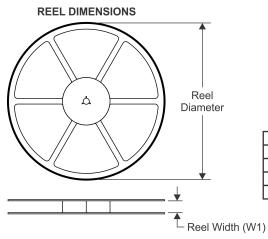
NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application

PACKAGE MATERIALS INFORMATION

www.ti.com 29-Apr-2014

TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVC374ADBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74LVC374ADGVR	TVSOP	DGV	20	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LVC374ADWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74LVC374ANSR	SO	NS	20	2000	330.0	24.4	8.2	13.0	2.5	12.0	24.0	Q1
SN74LVC374APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC374APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC374APWRG4	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC374APWT	TSSOP	PW	20	250	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC374ARGYR	VQFN	RGY	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1

www.ti.com 29-Apr-2014



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVC374ADBR	SSOP	DB	20	2000	367.0	367.0	38.0
SN74LVC374ADGVR	TVSOP	DGV	20	2000	367.0	367.0	35.0
SN74LVC374ADWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74LVC374ANSR	SO	NS	20	2000	367.0	367.0	45.0
SN74LVC374APWR	TSSOP	PW	20	2000	364.0	364.0	27.0
SN74LVC374APWR	TSSOP	PW	20	2000	367.0	367.0	38.0
SN74LVC374APWRG4	TSSOP	PW	20	2000	367.0	367.0	38.0
SN74LVC374APWT	TSSOP	PW	20	250	367.0	367.0	38.0
SN74LVC374ARGYR	VQFN	RGY	20	3000	367.0	367.0	35.0

14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

W (R-GDFP-F20)

CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.

 D. Index point is provided on cap for terminal identification only.

 E. Falls within Mil—Std 1835 GDFP2—F20



FK (S-CQCC-N**)

LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. Falls within JEDEC MS-004



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



DGV (R-PDSO-G**)

24 PINS SHOWN

PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194 DW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AC.



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



RGY (R-PVQFN-N20)

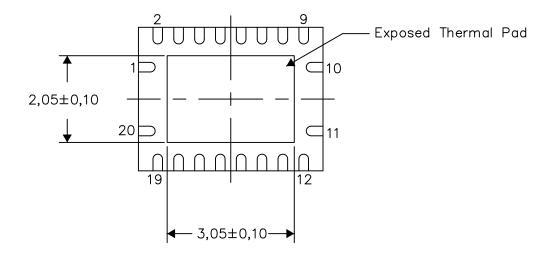
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

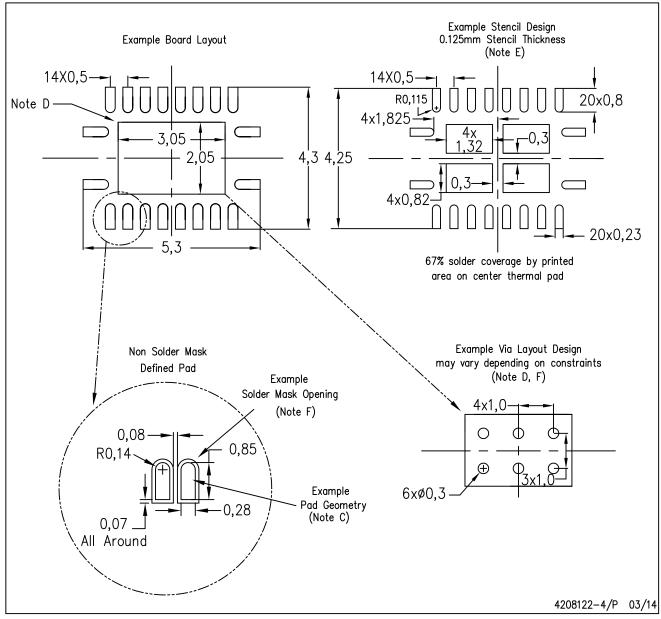
4206353-4/P 03/14

NOTE: All linear dimensions are in millimeters



RGY (R-PVQFN-N20)

PLASTIC QUAD FLATPACK NO-LEAD



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products Applications

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive Communications and Telecom Amplifiers amplifier.ti.com www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps

DSP **Energy and Lighting** dsp.ti.com www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical logic.ti.com Logic Security www.ti.com/security

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers <u>microcontroller.ti.com</u> Video and Imaging <u>www.ti.com/video</u>

RFID <u>www.ti-rfid.com</u>

OMAP Applications Processors <u>www.ti.com/omap</u> TI E2E Community <u>e2e.ti.com</u>

Wireless Connectivity <u>www.ti.com/wirelessconnectivity</u>